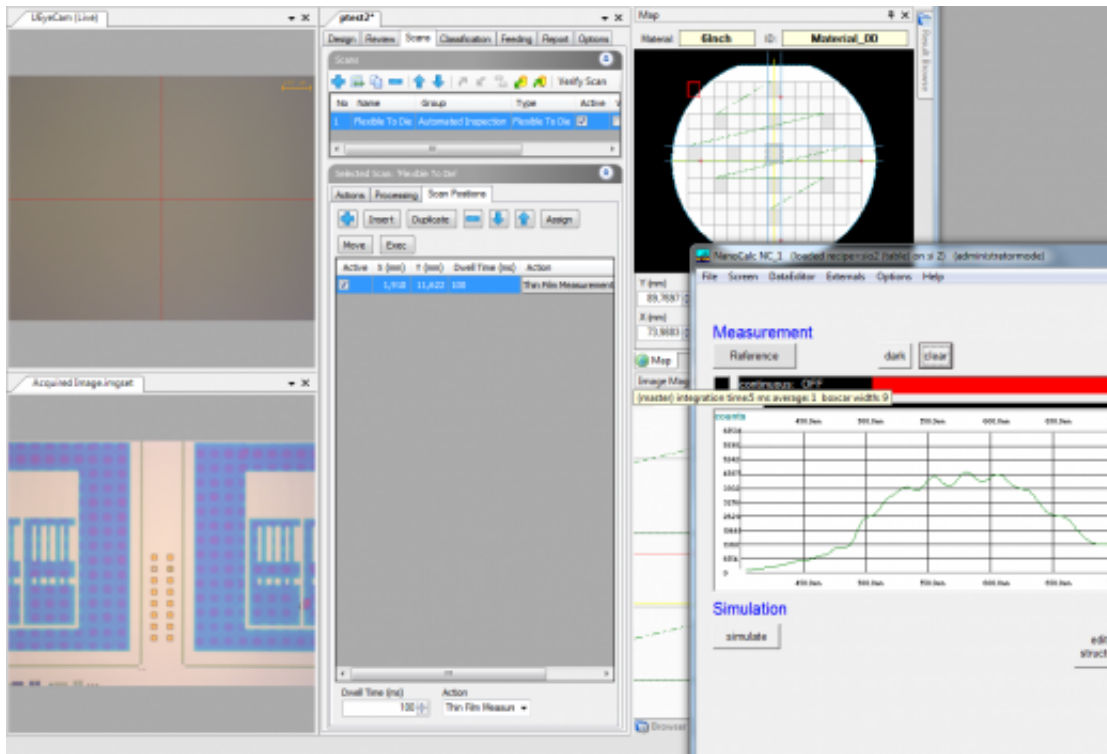
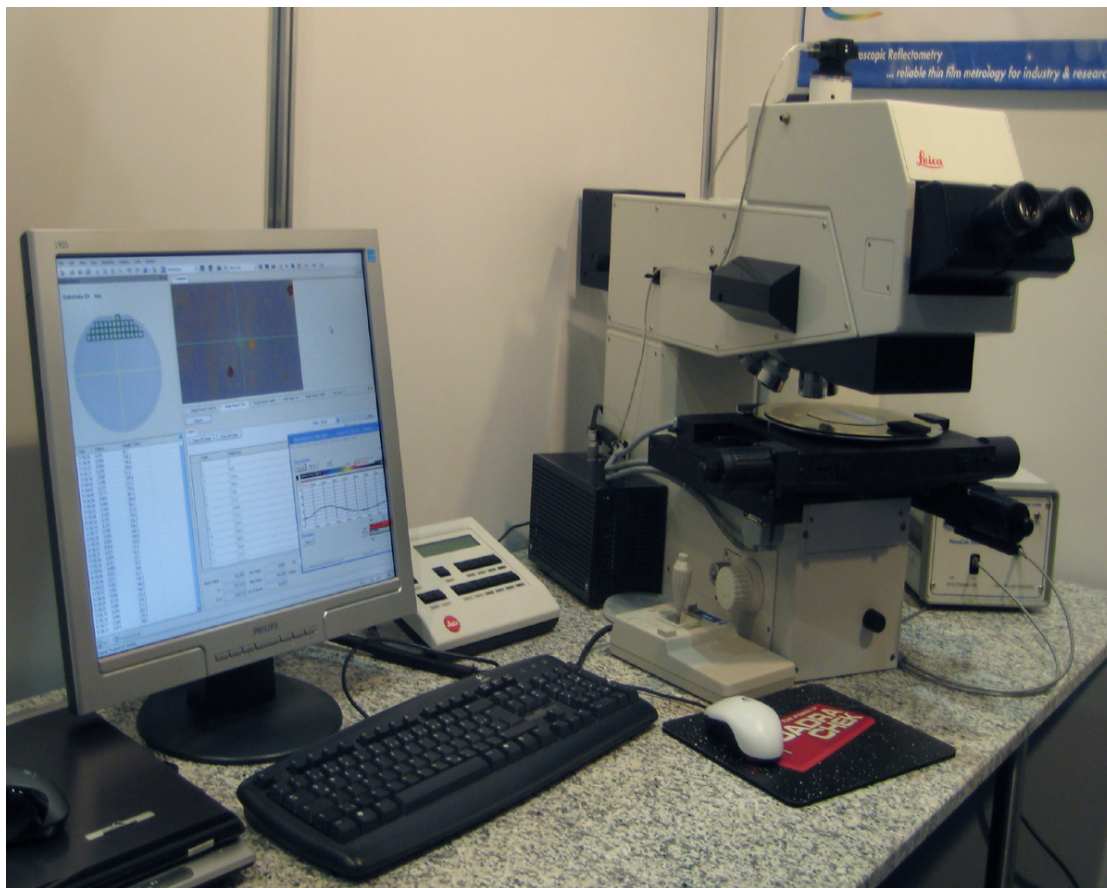


Thin Film Measurement

Microscope Thin Film Measurement



Powerful system for layer thicknesses between 50 nm and 50 μ m.



Semiconductor Fabrication:

- Photoresist
- Oxides
- Nitrides

Liquid Crystal Displays:

- Cell Gaps
- Polyimides
- ITO

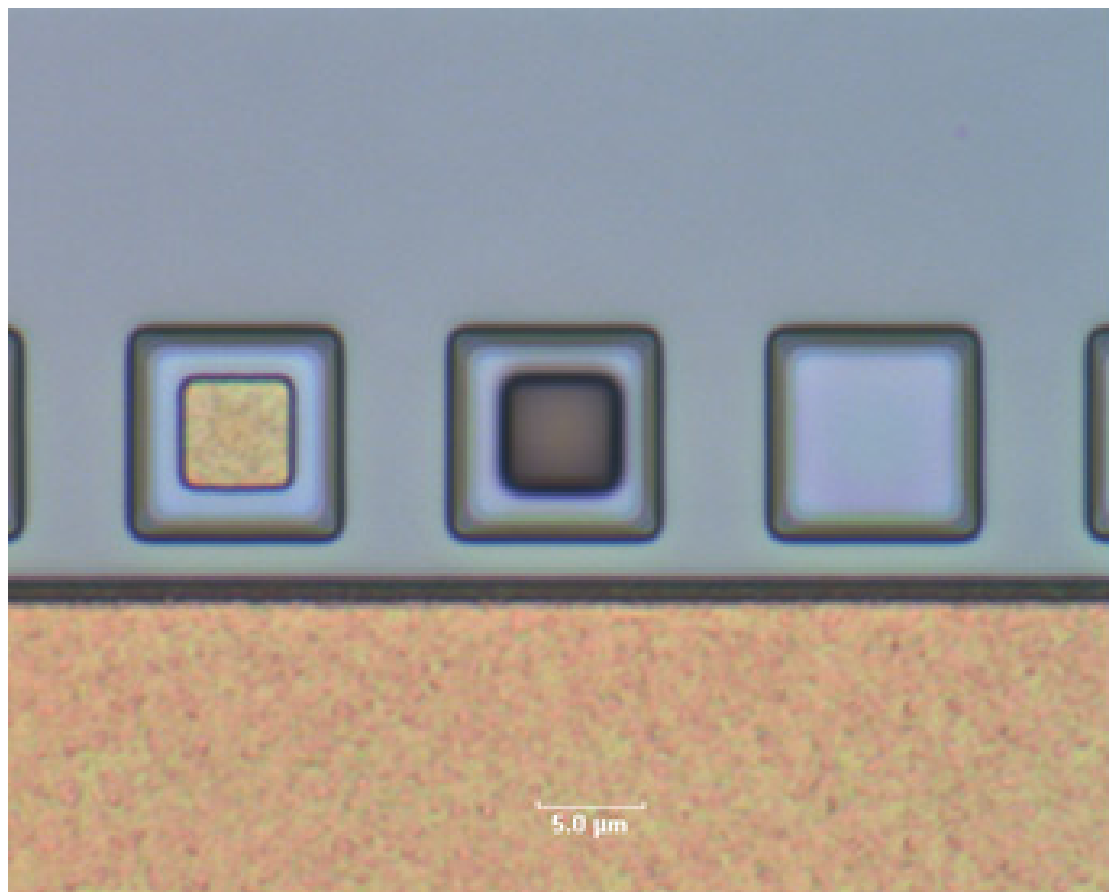
Optical Coatings:

- Hardness Coatings
- Anti-Reflection Coatings
- Filters

Promicron DM12000-TF



Universal semiconductor microscope with option for layer thickness measurement.



Enquiry